

Present status of x-ray fluorescence holographic studies at PF-KEK

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Abstract

At the beamline BL6C and BL15B1, we have recently carried out x-ray fluorescence holography (XFH) experiments on several functional materials, such as Shape Memory Alloy, DVD Materials, Ferromagnetic Films, Mixed Semiconducting Alloys, Dirac Insulator Materials. In this presentation, recent status of the XFH technique is introduced together with recent applications.

Recent publications

- Extent and feature of lattice distortions around Ga impurity atoms in InSb single crystal, S. Hosokawa, N. Happo, T. Ozaki, H. Ikemoto, T. Shishido, and K. Hayashi, Phys. Rev. B 87, 094104-1-8 (2013)
- [2] X-ray fluorescence holography, K. Hayashi, N. Happo, S. Hosokawa, W. Hu, and T. Matsushita, J. Phys.: Condens. Matter, (Topical Review) 24, 093201-1-15 (2012)
- [3] 蛍光X線ホログラフィーによる局所格子歪みの評価、林好一、八方直久、細川伸也、日本放射光学会誌、印刷中

Approved Projects

- 1. 2012G661, Tomoyuki Terai, Ti-Ni-Fe Shape Memory Alloy
- 2. 2011G530, Shinya Hosokawa, GeSbTe DVD Material
- 3. 2011G601, Naohisa Happo, Mn:ZnSnAs₂ Room-Temperature Ferromagnetic Film
- 4. 2012G757, Kouichi Hayashi, Low-Temperature Apparatus



XFH diffractometer installed at BL6C of PF-KEK





Example of Hologram





image









Bi2Te3: Mn Dirac Insulators

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